

ICS 71.040.40

CCS G 04



**NATIONAL STANDARD OF THE
PEOPLE'S REPUBLIC OF CHINA**

GB/T 29556-2013

**Surface chemical analysis -- Auger electron spectroscopy and X-ray
photoelectron spectroscopy -- Determination of lateral resolution,
analysis area, and sample area viewed by the analyser**

表面化学分析 俄歇电子能谱和X射线光电子能谱 横向分辨率、分析面积和分析器
所能检测到的样品面积的测定

(English Translation)

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What this standard covers

This standard specifies: Auger electron spectroscopy and X-ray photoelectron spectroscopy lateral resolution, analysis area and the analyzer can detect the sample size measurement method. This standard applies to Auger electron spectroscopy and X-ray phot

Document data

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